Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
10/617,172	KIM ET AL.
Examiner	Art Unit
Tianjie Chen	2627

SEARCHED					
Class	Subclass	Date	Examiner		
360	98.08				
	99.05				
	99.12	9/27/2006	TJ		

INTERFERENCE SEARCHED			
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